Improvement of power distribution network using correlation-based regression analysis

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Background

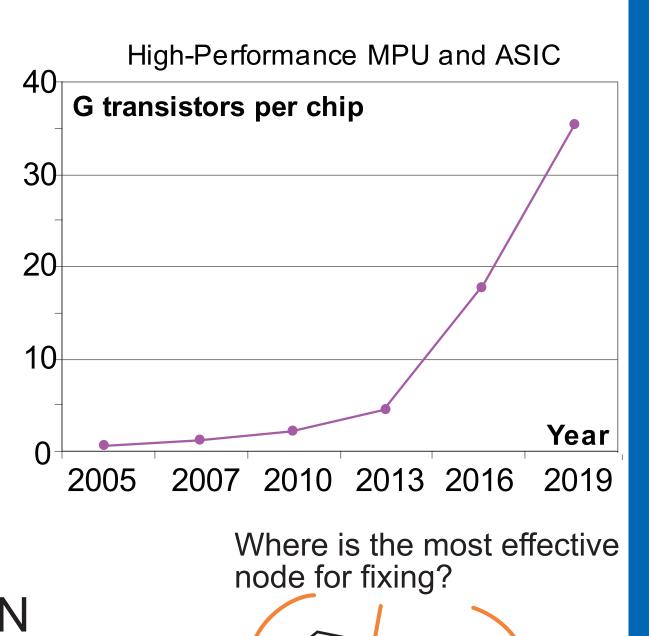
Supply voltage drop has significant impact on timing of logic circuits.



Improvement of PDN is required.

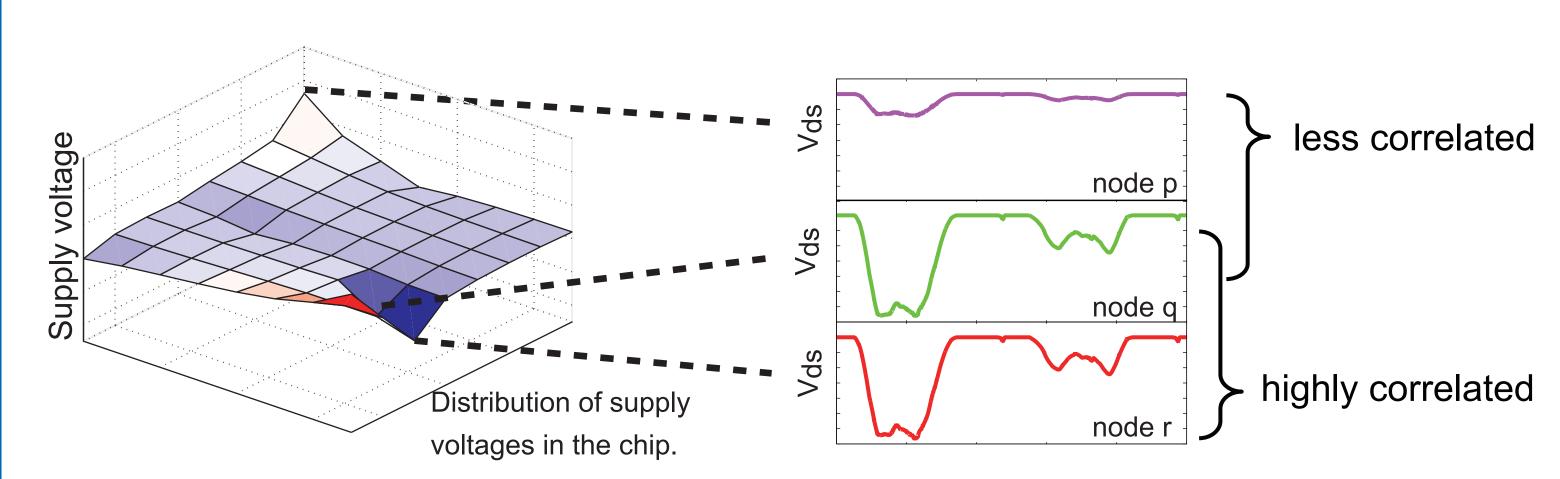
Integration of increasing number of transistors in an LSI makes following issues even more serious

- It requires long time to improve a PDN
- It is difficult to find where to repair
- No quantitative measure to compare PDNs

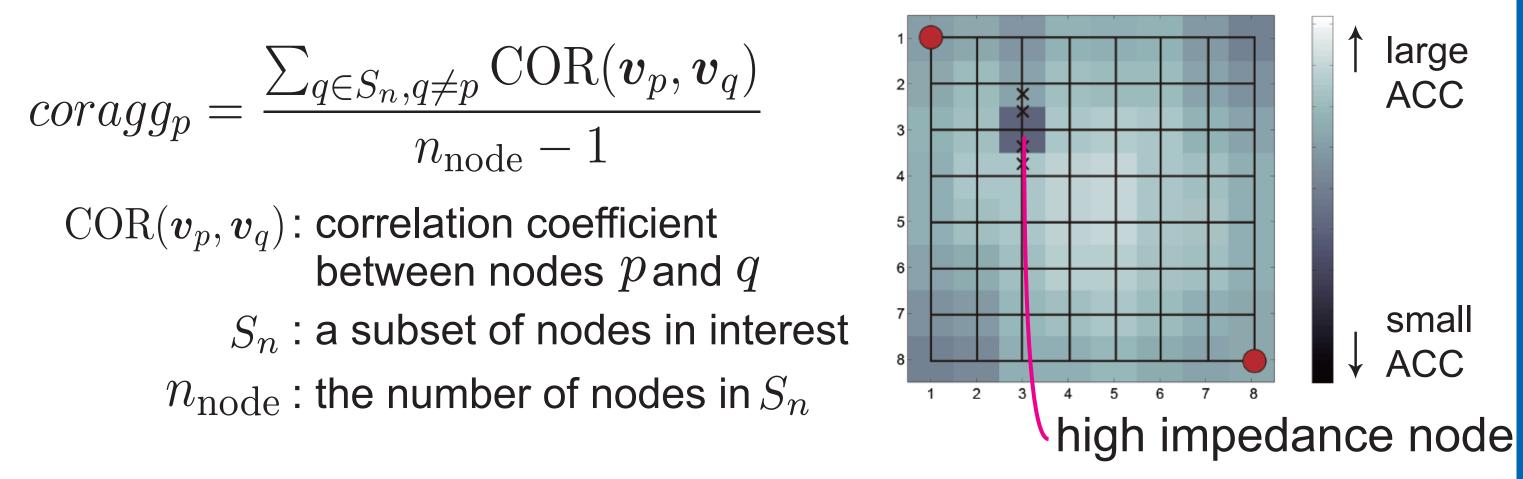


Aggregate correlation coefficient

Supply voltages in a chip is temporary and spatially dependent



To express the correlation with other nodes by one value, a new metric of aggregate correlation coefficient (ACC) is defined



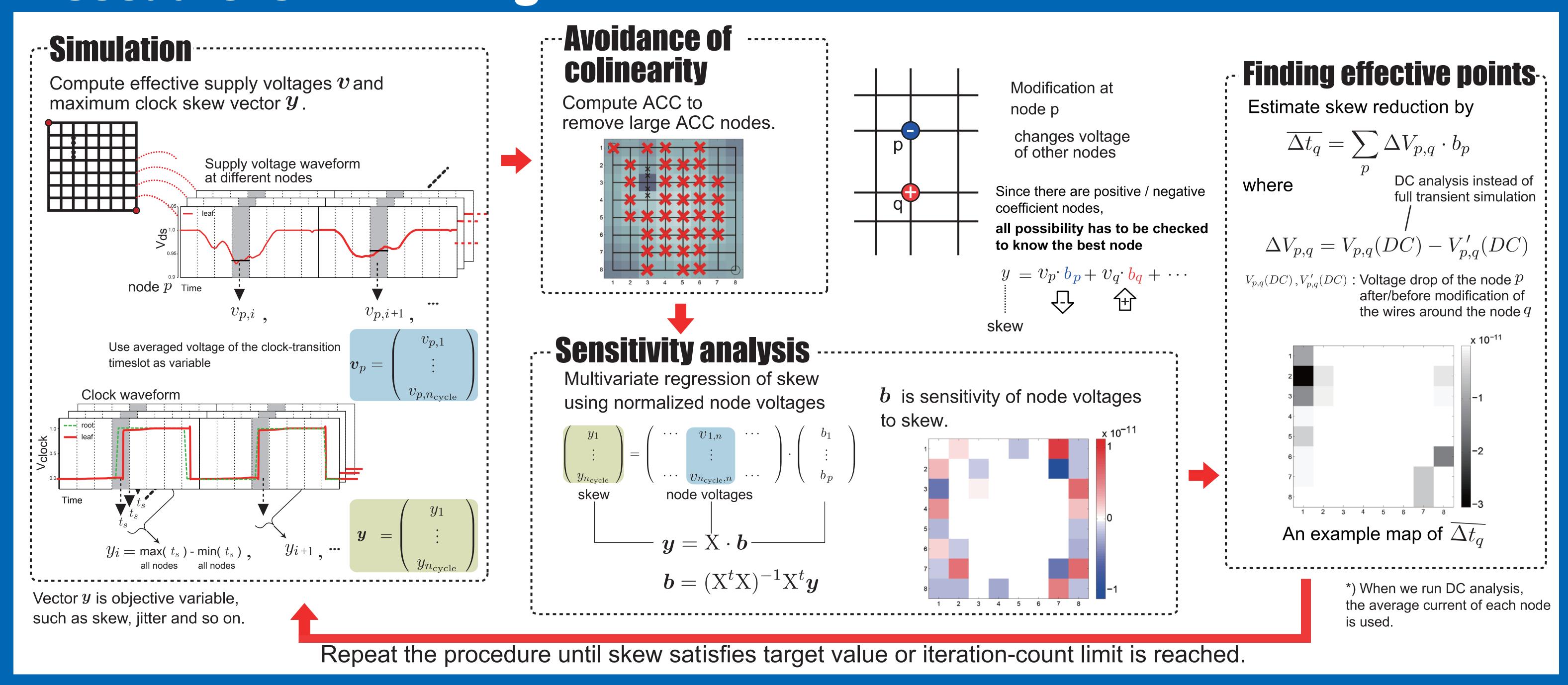
The ACC is a good measure for evaluating connectivities of a node
The ACC quantitates PDN including power consumption distribution

Objective

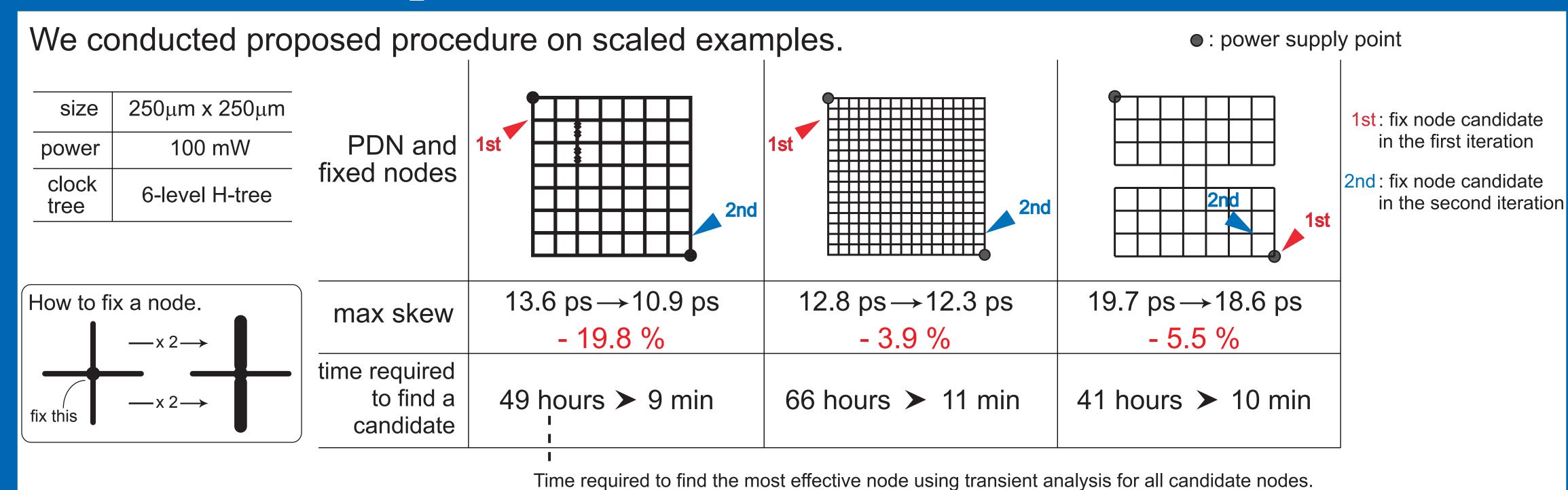
Statistical approaches are considered to

- propose a measure to quantitatively evaluate the connectivites of the PDN
- propose a procedure which efficiently find appropriate fixing points

Procedure for PDN fixing



Numerical experiments



Conclusion

- The ACC, a new metric which quantitatively evaluate node connection has been proposed.
 We can find isolated nodes using ACC.
- A procedure which efficiently find an appropriate point to improve PDN is proposed.

Efficient improvement of the given PDN becomes possible